

**N-Channel 30V (D-S) MOSFET**

**GENERAL DESCRIPTION**

The ME4174 is the N-Channel logic enhancement mode power field effect transistors are produced using high cell density, DMOS trench technology. This high density process is especially tailored to minimize on-state resistance. These devices are particularly suited for low voltage application such as cellular phone and notebook computer power management and other battery powered circuits where high-side switching, and low in-line power loss are needed in a very small outline surface mount package.

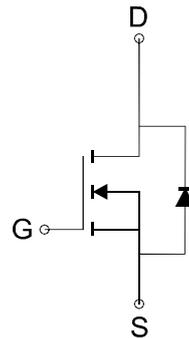
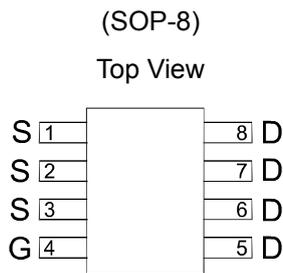
**FEATURES**

- $R_{DS(ON)} \leq 6.2m\Omega @ V_{GS}=10V$
- $R_{DS(ON)} \leq 11m\Omega @ V_{GS}=4.5V$
- Super high density cell design for extremely low  $R_{DS(ON)}$
- Exceptional on-resistance and maximum DC current capability

**APPLICATIONS**

- Power Management in Note book
- Portable Equipment
- Battery Powered System
- DC/DC Converter
- Load Switch
- DSC
- LCD Display inverter

**PIN CONFIGURATION**



Ordering Information: ME4174 (Pb-free)

ME4174-G (Green product-Halogen free)

N-Channel MOSFET

**Absolute Maximum Ratings (TA=25°C Unless Otherwise Noted)**

Parameter	Symbol	Steady State	Unit
Drain-Source Voltage	$V_{DSS}$	30	V
Gate-Source Voltage	$V_{GSS}$	$\pm 20$	V
Continuous Drain Current (Tj=150°C)	$I_D$	TA=25°C	15.8
		TA=70°C	12.7
Pulsed Drain Current	$I_{DM}$	64	A
Maximum Power Dissipation	$P_D$	TA=25°C	2.5
		TA=70°C	1.6
Operating Junction Temperature	$T_J$	-55 to 150	°C
Thermal Resistance-Junction to Ambient*	$R_{\theta JA}$	Steady State	50
			°C/W

\*The device mounted on 1in<sup>2</sup> FR4 board with 2 oz copper

## N-Channel 30V (D-S) MOSFET

Electrical Characteristics (T<sub>A</sub>=25°C Unless Otherwise Specified)

Symbol	Parameter	Limit	Min	Typ	Max	Unit
<b>STATIC</b>						
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250 μA	1.0		3.0	V
I <sub>GSS</sub>	Gate Leakage Current	V <sub>DS</sub> =0V, V <sub>GS</sub> =±20V			±10	μA
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> =30V, V <sub>GS</sub> =0V			1	μA
R <sub>DS(ON)</sub>	Drain-Source On-State Resistance <sup>a</sup>	V <sub>GS</sub> =10V, I <sub>D</sub> = 30A		5.2	6.2	mΩ
		V <sub>GS</sub> =4.5V, I <sub>D</sub> = 15A		8.2	11	
V <sub>SD</sub>	Diode Forward Voltage	I <sub>S</sub> =20A, V <sub>GS</sub> =0V		0.8	1.2	V
<b>DYNAMIC</b>						
Q <sub>g</sub>	Gate Charge	V <sub>DS</sub> =15V, V <sub>GS</sub> =10V, I <sub>D</sub> =25A		37		nC
Q <sub>gt</sub>	Total Gate Charge	V <sub>DS</sub> =15V, V <sub>GS</sub> =4.5V, I <sub>D</sub> =25A		19		
Q <sub>gs</sub>	Gate-Source Charge			8		
Q <sub>gd</sub>	Gate-Drain Charge			9		
C <sub>iss</sub>	Input capacitance	V <sub>DS</sub> =15V, V <sub>GS</sub> =0V, f=1MHz		1640		pF
C <sub>oss</sub>	Output Capacitance			260		
C <sub>rss</sub>	Reverse Transfer Capacitance			84		
R <sub>g</sub>	Gate Resistance	f =1MHz		0.9		Ω
t <sub>d(on)</sub>	Turn-On Delay Time	V <sub>DD</sub> =15V, R <sub>L</sub> =15Ω I <sub>D</sub> =1A, V <sub>GEN</sub> =10V R <sub>G</sub> =3Ω		19		ns
t <sub>r</sub>	Turn-On Rise Time			15		
t <sub>d(off)</sub>	Turn-Off Delay Time			54		
t <sub>f</sub>	Turn-On Fall Time			6.5		

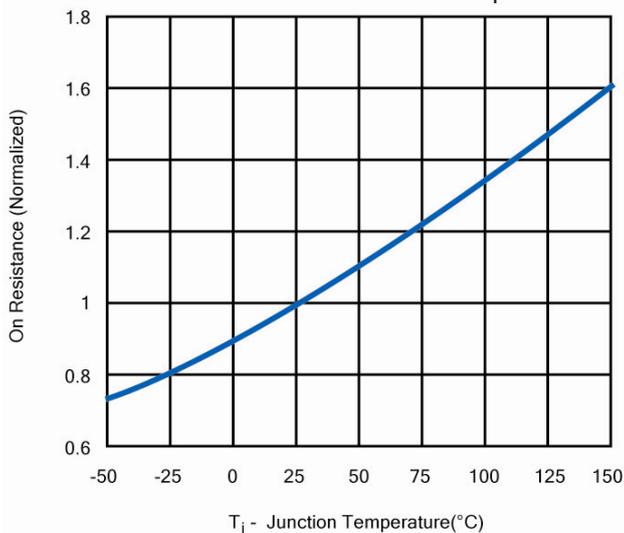
Notes: a. Pulse test: pulse width ≤ 300us, duty cycle ≤ 2%, Guaranteed by design, not subject to production testing.

b. Matsuki reserves the right to improve product design, functions and reliability without notice.

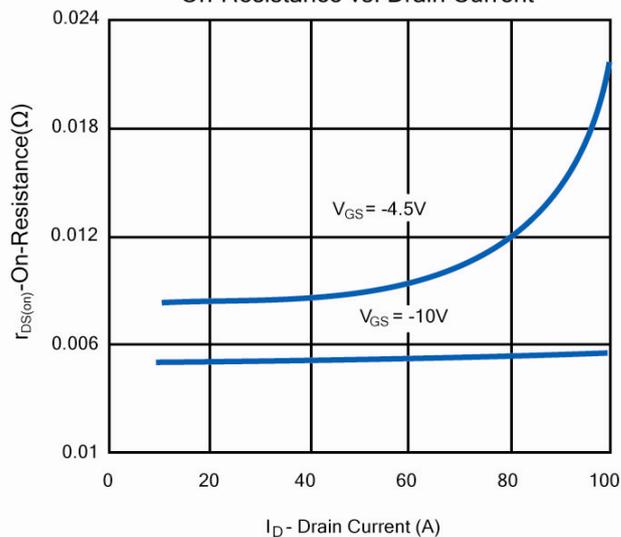
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**Typical Characteristics (T<sub>J</sub> = 25°C Noted)**

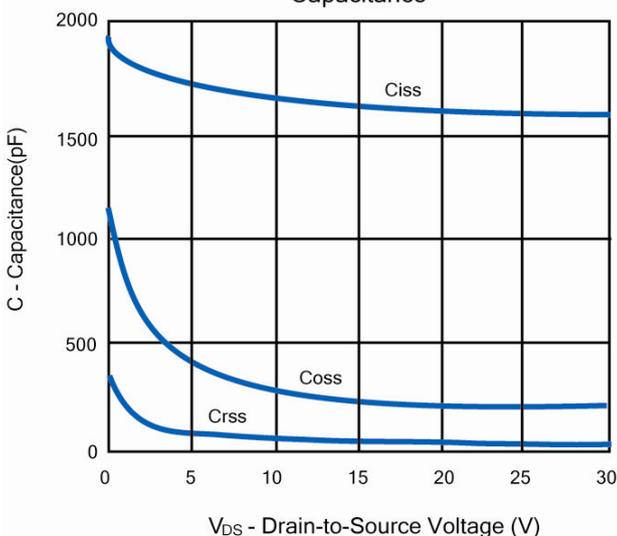
On Resistance vs. Junction Temperature



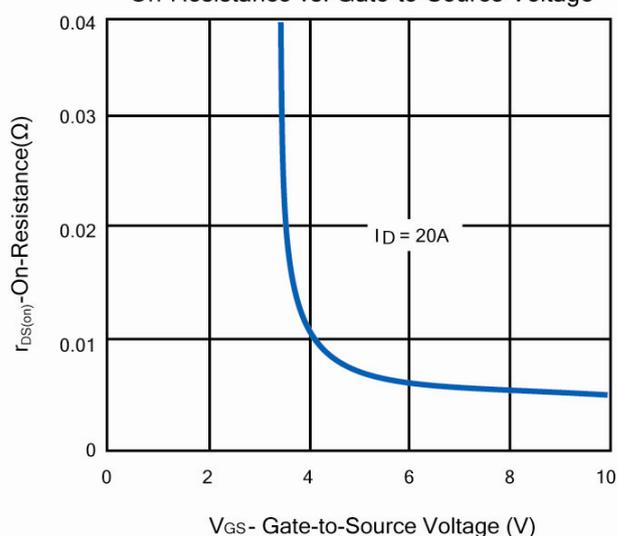
On-Resistance vs. Drain Current



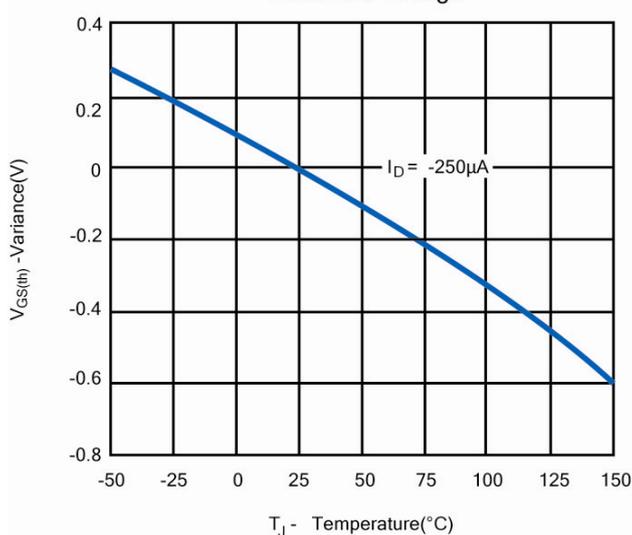
Capacitance



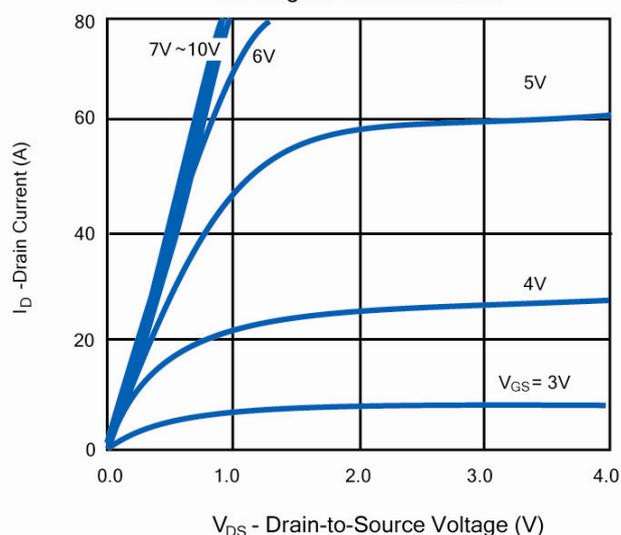
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage



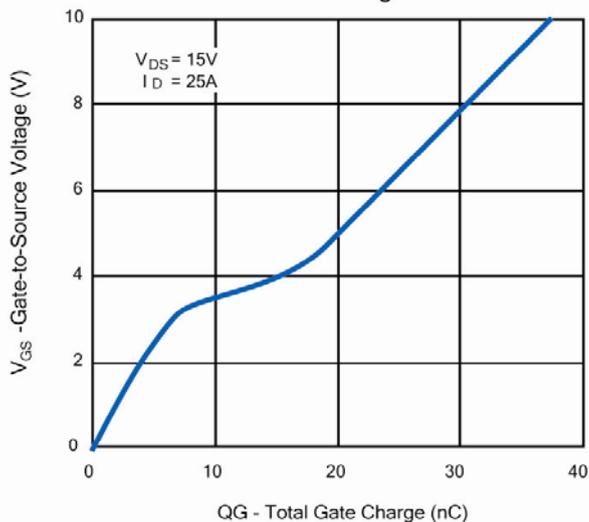
On-Region Characteristics



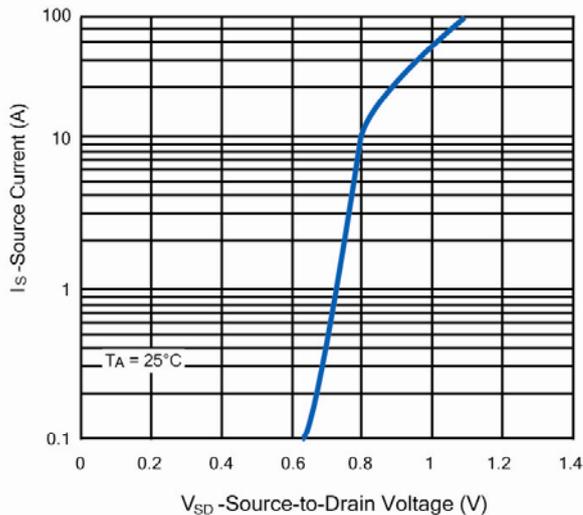
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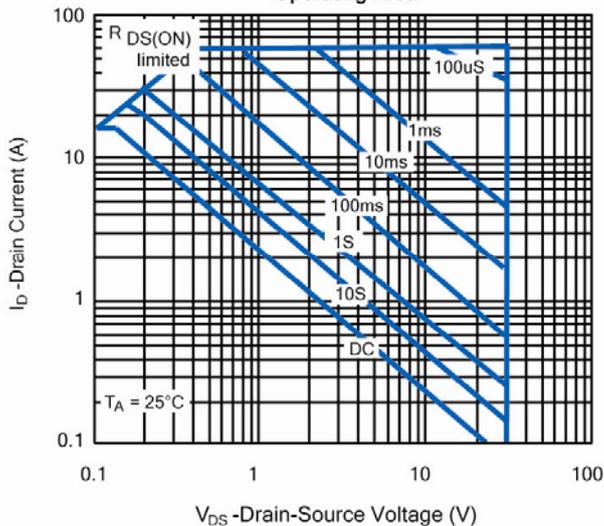
Gate Charge



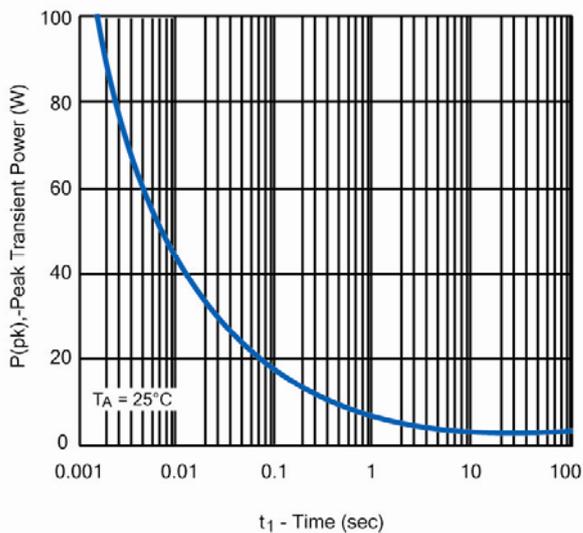
**Source to Drain Diode Forward Voltage**



**Maximum Forward Biased Safe Operating Area**



**Single Pulse Maximum Power Dissipation**



**Normalized Thermal Transient Impedance, Junction-to-Ambient**

